



#### 40V N-CHANNEL ENHANCEMENT MODE MOSFET

## **Product Summary**

BV <sub>DSS</sub>	R <sub>DS(ON)</sub> max	I <sub>D</sub> max T <sub>A</sub> = +25°C
401/	21mΩ @ V <sub>GS</sub> = 10V	8.6A
40V	$28m\Omega$ @ $V_{GS} = 4.5V$	6.9A

#### Features and Benefits

- 0.6mm Profile Ideal for Low Profile Applications
- PCB Footprint of 4mm<sup>2</sup>
- Low Gate Threshold Voltage
- Low On-Resistance
- Totally Lead-Free & Fully RoHS Compliant (Notes 1 & 2)
- Halogen- and Antimony-Free. "Green" Device (Note 3)
- The DMN4020LFDEQ is suitable for automotive applications requiring specific change control; this part is AEC-Q101 qualified, PPAP capable, and manufactured in IATF 16949 certified facilities.

https://www.diodes.com/quality/product-definitions/

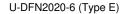
## **Description and Applications**

This MOSFET is designed to meet the stringent requirements of automotive applications. It is AEC-Q101 qualified, supported by a PPAP, and is ideal for use in:

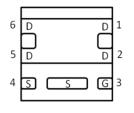
- General Purpose Interfacing Switch
- Power Management Functions

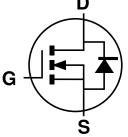
### **Mechanical Data**

- Case: U-DFN2020-6
- Case Material: Molded Plastic, "Green" Molding Compound. UL Flammability Classification Rating 94V-0
- Moisture Sensitivity: Level 1 per J-STD-020
- Terminals: Finish NiPdAu over Copper Lead-Frame. Solderable per MIL-STD-202, Method 208 @4
- Weight: 0.0065 grams (Approximate)









**Bottom View** 

Pin Out

**Equivalent Circuit** 

#### **Ordering Information** (Note 4)

Part Number	Case	Quantity Per Reel
DMN4020LFDEQ-7	U-DFN2020-6 (Type E)	3,000
DMN4020LFDEQ-13	U-DFN2020-6 (Type E)	10,000

Notes:

- 1. No purposely added lead. Fully EU Directive 2002/95/EC (RoHS), 2011/65/EU (RoHS 2) & 2015/863/EU (RoHS 3) compliant.
- 2. See https://www.diodes.com/quality/lead-free/ for more information about Diodes Incorporated's definitions of Halogen- and Antimony-free, "Green" and Lead-free.
- 3. Halogen- and Antimony-free "Green" products are defined as those which contain <900ppm bromine, <900ppm chlorine (<1500ppm total Br + CI) and <1000ppm antimony compounds.
- 4. For packaging details, go to our website at https://www.diodes.com/design/support/packaging/diodes-packaging/.

# **Marking Information**



NE = Product Type Marking Code YWX = Date Code Marking Y = Year (ex: 0 = 2020)

W = Week (ex: a = week 27; z represents week 52 and 53)

X = Internal Code (ex: U = Monday)

Date Gode Key												
Year	2020	2021	2022	2023	2024	2025	2026	2027	2028	2029	2030	2031
Code	0	1	2	3	4	5	6	7	8	9	0	1
Week	1-26			27-52			53					
Code	A-Z			a-z			Z					
	·											
Internal Code	Sui	า	Mon		Tue	W	ed	Thu		Fri		Sat
Codo	Т		11		17	١.	۸/	V		V		7



## **Maximum Ratings** (@ T<sub>A</sub> = +25°C, unless otherwise specified.)

Characteristic	Symbol	Value	Unit		
Drain-Source Voltage			$V_{DSS}$	40	V
Gate-Source Voltage	$V_{GSS}$	±20	V		
Continuous Drain Current (Note 6) V <sub>GS</sub> = 10V	I <sub>D</sub>	8.6 6.9	А		
Pulsed Drain Current (10μs Pulse, Duty Cycle = 1%	I <sub>DM</sub>	40	Α		
Maximum Body Diode Continuous Current	Is	8.6	Α		
Pulsed Body Diode Forward Current (10µs Pulse, D	I <sub>SM</sub>	40	Α		
Avalanche Current (Note 7) L = 0.1mH	I <sub>AS</sub>	22.4	Α		
Avalanche Energy (Note 7) L = 0.1mH	E <sub>AS</sub>	25	mJ		

# Thermal Characteristics (@ T<sub>A</sub> = +25°C, unless otherwise specified.)

Characteristic	Symbol	Value	Unit		
Total Power Dissipation (Note 5)	$T_A = +25^{\circ}C$	В	0.85	W	
Total Fower Dissipation (Note 5)	$T_A = +70^{\circ}C$	$P_D$	0.54	VV	
Thermal Resistance, Junction to Ambient (Note 5)	$R_{ heta JA}$	147.6	°C/W		
Total Power Dissipation (Note 6) $\frac{T_A = +}{T_A = +}$		В	2.35	W	
		P <sub>D</sub>	1.5	VV	
Thermal Resistance, Junction to Ambient (Note 6)	$R_{ heta JA}$	53.3	°C/W		
Thermal Resistance, Junction to Case (Note 6)	$R_{\theta JC}$	6.9	*G/ <b>VV</b>		
Operating and Storage Temperature Range	T <sub>J,</sub> T <sub>STG</sub>	-55 to +150	°C		

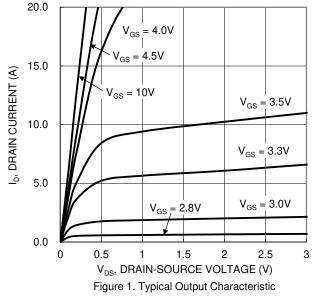
# Electrical Characteristics (@ T<sub>A</sub> = +25°C, unless otherwise specified.)

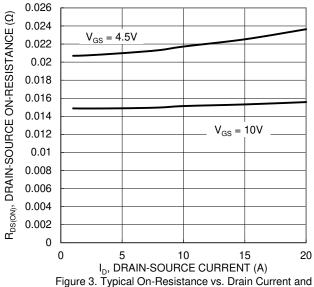
Characteristic	Symbol	Min	Тур	Max	Unit	Test Condition
OFF CHARACTERISTICS (Note 8)						
Drain-Source Breakdown Voltage	BV <sub>DSS</sub>	40	_	_	V	$V_{GS} = 0V, I_D = 250\mu A$
Zero Gate Voltage Drain Current T <sub>J</sub> = +25°C	I <sub>DSS</sub>	1	_	1	μΑ	$V_{DS} = 40V, V_{GS} = 0V$
Gate-Source Leakage	I <sub>GSS</sub>	_	_	±100	nA	$V_{GS} = \pm 20V, V_{DS} = 0V$
ON CHARACTERISTICS (Note 8)						
Gate Threshold Voltage	$V_{GS(TH)}$	1.4		2.4	V	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$
Static Drain-Source On-Resistance			15	21	mΩ	$V_{GS} = 10V, I_{D} = 8A$
Static Drain-Source On-nesistance	R <sub>DS(ON)</sub>		20	28	11122	$V_{GS} = 4.5V, I_D = 4A$
Diode Forward Voltage	$V_{SD}$	1	0.7	1	V	$V_{GS} = 0V, I_{S} = 1A$
DYNAMIC CHARACTERISTICS (Note 9)						
Input Capacitance	$C_iss$	_	1201		рF	V 20V V 0V
Output Capacitance	$C_{oss}$	_	87	_	рF	$V_{DS} = 20V, V_{GS} = 0V,$ f = 1.0MHz
Reverse Transfer Capacitance	$C_{rss}$		58		рF	1 = 1.000112
Gate Resistance	$R_{g}$		1.3		Ω	$V_{DS} = 0V$ , $V_{GS} = 0V$ , $f = 1MHz$
Total Gate Charge (V <sub>GS</sub> = 4.5V)	$Q_g$	_	12.7	_	nC	
Total Gate Charge (V <sub>GS</sub> = 10V)	Qg		25.3		nC	V 20V I- 9A
Gate-Source Charge	$Q_gs$	_	5.6	_	nC	$V_{DS} = 20V, I_{D} = 8A$
Gate-Drain Charge	$Q_{gd}$		4.4		nC	
Turn-On Delay Time	t <sub>D(ON)</sub>	_	8	_	ns	
Turn-On Rise Time	t <sub>R</sub>	_	2.6	_	ns	$V_{DS} = 20V, R_{L} = 2.5\Omega$
Turn-Off Delay Time	t <sub>D(OFF)</sub>		17	_	ns	$V_{GS} = 10V, R_G = 3\Omega$
Turn-Off Fall Time	t <sub>F</sub>	_	8.9	_	ns	]
Reverse Recovery Time	t <sub>RR</sub>		17.5	_	ns	1 00 4:/44 1000///-
Reverse Recovery Charge	Q <sub>RR</sub>	_	8.9	_	nC	$I_F = 8A$ , di/dt = 100A/ $\mu$ s

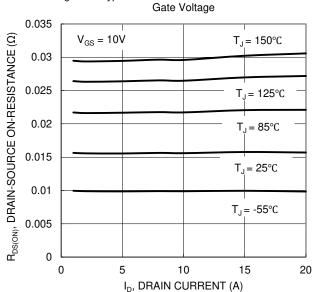
Notes:

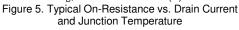
- 5. Device mounted on FR-4 substrate PC board, 2oz copper, with minimum recommended pad layout. 6. Device mounted on FR-4 substrate PC board, 2oz copper, with 1inch square pad layout. 7.  $I_{AS}$  and  $E_{AS}$  ratings are based on low frequency and duty cycles to keep  $T_{J}$  = +25°C. 8. Short duration pulse test used to minimize self-heating effect. 9. Guaranteed by design. Not subject to production testing.

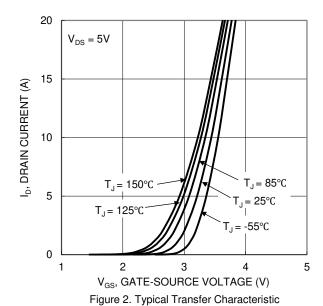


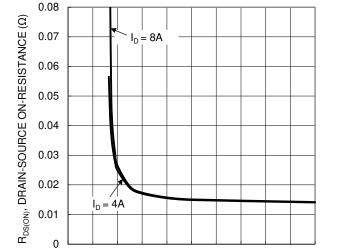












10 12 14

V<sub>GS</sub>, GATE-SOURCE VOLTAGE (V)

Figure 4. Typical Transfer Characteristic

16 18

0 2

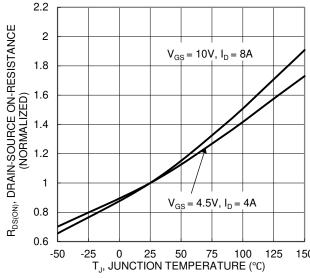


Figure 6. On-Resistance Variation with Junction Temperature



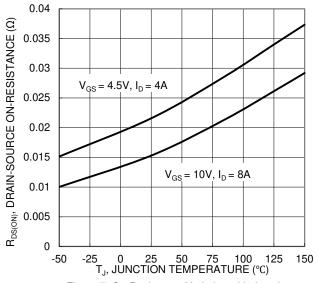


Figure 7. On-Resistance Variation with Junction Temperature

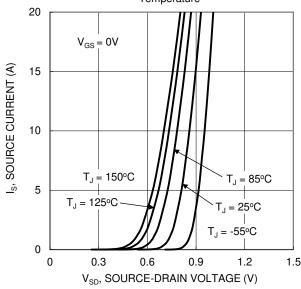


Figure 9. Diode Forward Voltage vs. Current

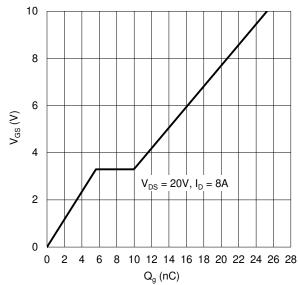


Figure 11. Gate Charge

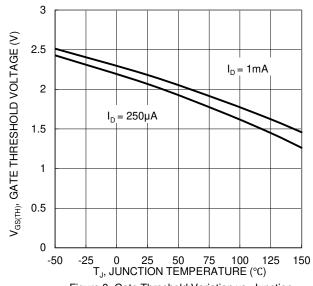


Figure 8. Gate Threshold Variation vs. Junction Temperature

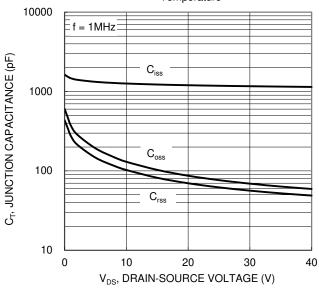
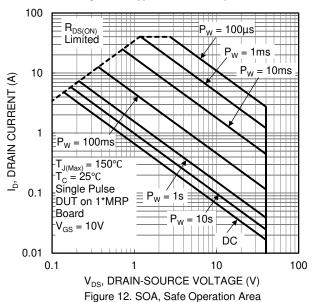


Figure 10. Typical Junction Capacitance





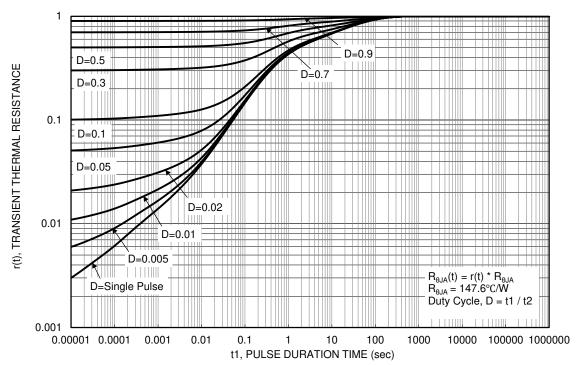
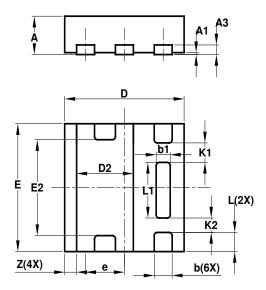


Figure 13. Transient Thermal Resistance



# **Package Outline Dimensions**

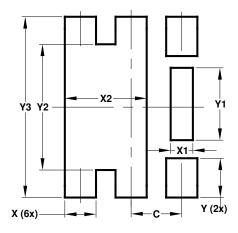
Please see http://www.diodes.com/package-outlines.html for the latest version.



U-DFN2020-6 Type E									
Dim									
Α	0.57	0.63	0.60						
<b>A</b> 1	0	0.05	0.03						
А3	_	_	0.15						
b	0.25	0.35	0.30						
b1	0.185	0.285	0.235						
D	1.95	2.05	2.00						
D2	0.85	1.05	0.95						
Е	1.95	2.05	2.00						
E2	1.40	1.60	1.50						
е	_	_	0.65						
L	0.25	0.35	0.30						
L1	0.82	0.92	0.87						
K1	_		0.305						
K2	_		0.225						
Z	_	_	0.20						
All Dimensions in mm									

# **Suggested Pad Layout**

Please see http://www.diodes.com/package-outlines.html for the latest version.



Dimensions	Value (in mm)				
HILIEUSIONS					
С	0.650				
X	0.400				
X1	0.285				
X2	1.050				
Υ	0.500				
Y1	0.920				
Y2	1.600				
Y3	2.300				

July 2020



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